

BGS8M4UK

SiGe:C Low Noise Amplifier MMIC with bypass switch for LTE

Rev. 1 — 1 December 2015

Product data sheet

1. Product profile

1.1 General description

The BGS8M4UK is a Low Noise Amplifier (LNA) with bypass switch for LTE receiver applications, available in a Wafer Level Chip-Scale Package (WLCSP). The BGS8M4UK requires one external matching inductor.

The BGS8M4UK delivers system-optimized gain for both primary and diversity applications where sensitivity improvement is required. The high linearity of this low noise device ensures the required receive sensitivity independent of cellular transmit power level in Frequency Division Duplex (FDD) systems. When receive signal strength is sufficient, the BGS8M4UK can be switched off to operate in bypass mode at a 1 μ A current, to lower power consumption. The BGS8M4UK requires only one external matching inductor.

The BGS8M4UK is optimized for 1805 MHz to 2200 MHz.

1.2 Features and benefits

- Operating frequency from 1805 MHz to 2200 MHz
- Noise figure (NF) = 0.8 dB
- Gain 16.6 dB
- High input 1 dB compression point of -6.5 dBm
- Bypass switch insertion loss of -2.7 dB
- High in band IP_{3i} of -0.5 dBm
- Supply voltage 1.5 V to 3.1 V
- Integrated supply decoupling capacitor
- Optimized performance at a supply current of 4.4 mA
- Bypass mode current consumption < 1 μ A
- Integrated temperature stabilized bias for easy design
- Requires only one input matching inductor
- Input and Output AC coupled
- ESD protection on all pins (HBM > 2 kV)
- Integrated matching for the output
- Extremely small Wafer Level Chip-Scale Package (WLCSP)
6 bumps; 0.69 mm $\times$ 0.44 mm $\times$ 0.29 mm; 0.25 mm / 0.26 mm bump pitch
- 180 GHz transit frequency - SiGe:C technology
- Moisture sensitivity level of 1



1.3 Applications

- LNA for LTE reception in smart phones, feature phones, tablet PCs and RF front-end modules.

1.4 Quick reference data

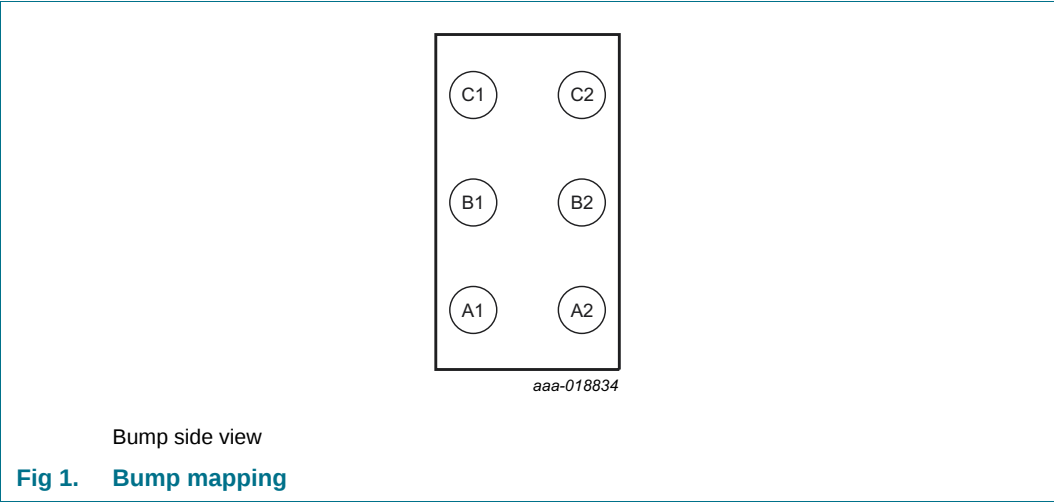
Table 1. Quick reference data
f = 1960 MHz; *V*_{CC} = 2.8 V; *V*_{I(CTRL)} ≥ 0.8 V; *T*_{amb} = 25 °C; input matched to 50 Ω using a 4.7 nH inductor in series; see [Figure 4](#) unless otherwise specified.

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
V _{CC}	supply voltage		1.5	-	3.1	V
I _{CC}	supply current	in gain mode	-	4.4	-	mA
		in bypass mode; 0.1 V ≤ <i>V</i> _{I(CTRL)} ≤ 0.3 V	-		1	μA
G _p	power gain	in gain mode [1]	-	16.6	-	dB
		in bypass mode [1]	-	-2.7	-	dB
NF	noise figure	[1] [2]	-	0.8	-	dB
P _{I(1dB)}	input power at 1 dB gain compression	[1]	-	-6.5	-	dBm
IP3 _i	input third-order intercept point	[1]	-	-0.5	-	dBm

- [1] E-UTRA operating band 2 (1930 MHz to 1990 MHz).
[2] PCB losses are subtracted.

2. Pinning information

2.1 Pinning



2.2 Pin description

Table 2. Ball description

Symbol	Pad	Description
GND	A1	ground
V _{CC}	B1	supply voltage
RF_OUT	C1	RF out
CTRL	A2	gain control, switch between gain and bypass mode
RF_IN	B2	RF in
GND_RF	C2	ground RF

3. Ordering information

Table 3. Ordering information

Type number	Package		
	Name	Description	Version
BGS8M4UK	WLCSP6	wafer level chip-scale package; 6 bumps; 0.69 × 0.44 × 0.29 mm	SOT1445-1

4. Marking

Table 4. Marking codes

Type number	Marking code
BGS8M4UK	single character, indicating assembly month. ^[1]

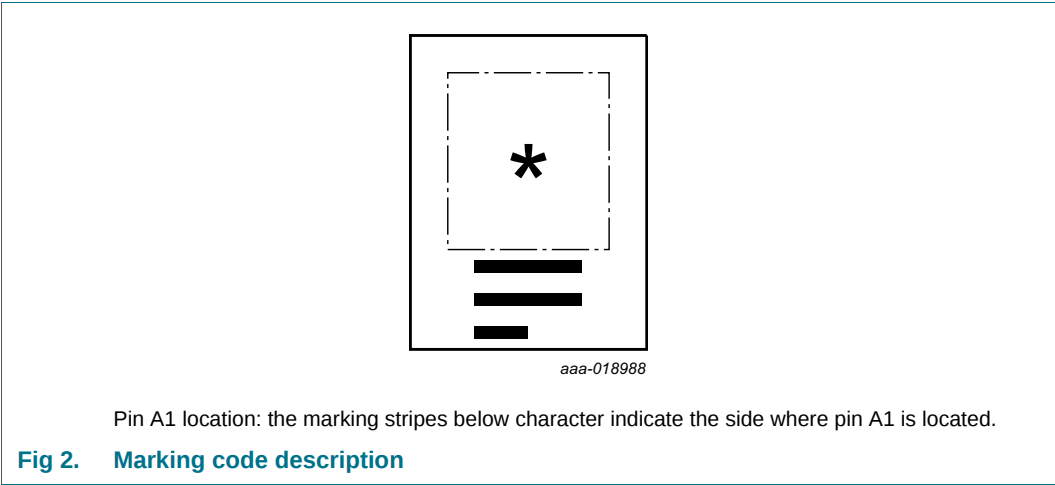
[1] Month code see [Table 5](#).

Table 5. Calender marking month code

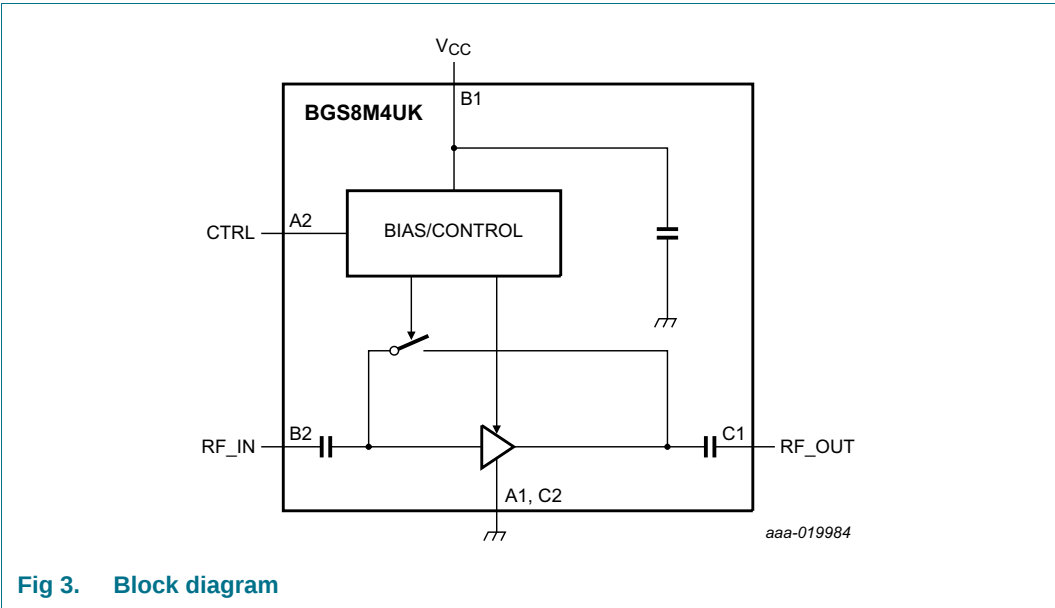
Asterisk (*) is replaced by character in table, see [Figure 2](#).

Year	Month											
	J	F	M	A	M	J	J	A	S	O	N	D
2015	A	B	C	D	E	F	G	H	I	J	K	L
2016	M	N	O	P	Q	R	S	T	U	V	W	X
2017	Y	Z	b	d	f	h	3	4	5	6	7	8

[1] Rotates every 3 years.



5. Block diagram



6. Limiting values

Table 6. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).
Absolute Maximum Ratings are given as Limiting Values of stress conditions during operation, that must not be exceeded under the worst probable conditions.

Symbol	Parameter	Conditions	Min	Max	Unit
V _{CC}	supply voltage	[1]	−0.5	+5.0	V
V _{I(CTRL)}	input voltage on pin CTRL	V _{I(CTRL)} < V _{CC} + 0.6 V [1][2]	−0.5	+5.0	V
V _{I(RF_IN)}	input voltage on pin RF_IN	DC, V _{I(RF_IN)} < V _{CC} + 0.6 V [1][2][3]	−0.5	+5.0	V
V _{I(RF_OUT)}	input voltage on pin RF_OUT	DC, V _{I(RF_OUT)} < V _{CC} + 0.6 V [1][2][3]	−0.5	+5.0	V
P _i	input power	[1]	-	10	dBm

Table 6. Limiting values ...continued

In accordance with the Absolute Maximum Rating System (IEC 60134).

Absolute Maximum Ratings are given as Limiting Values of stress conditions during operation, that must not be exceeded under the worst probable conditions.

Symbol	Parameter	Conditions	Min	Max	Unit
P_{tot}	total power dissipation	$T_{\text{sp}} \leq 130\text{ }^{\circ}\text{C}$	-	55	mW
T_{stg}	storage temperature		-65	+150	$^{\circ}\text{C}$
T_{j}	junction temperature		-	150	$^{\circ}\text{C}$
V_{ESD}	electrostatic discharge voltage	Human Body Model (HBM) According to ANSI/ESDA/JEDEC standard JS-001	-	± 2	kV
		Charged Device Model (CDM) According to JEDEC standard JESD22-C101C	-	± 1	kV

[1] Stressed with pulses of 200 ms in duration.

[2] Warning: due to internal ESD diode protection, the applied DC voltage shall not exceed $V_{\text{CC}} + 0.6\text{ V}$ and shall not exceed 5.0 V in order to avoid excess current.

[3] The RF input and output are AC coupled through internal DC blocking capacitors.

7. Recommended operating conditions

Table 7. Operating conditions

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
V_{CC}	supply voltage		1.5	-	3.1	V
T_{amb}	ambient temperature		-40	+25	+85	$^{\circ}\text{C}$
$V_{\text{I(CTRL)}}$	input voltage on pin CTRL	bypass mode	-	-	0.25	V
		ON state	0.8	-	-	V

8. Thermal characteristics

Table 8. Thermal characteristics

Symbol	Parameter	Conditions	Typ	Unit
$R_{\text{th(j-sp)}}$	thermal resistance from junction to solder point		225	K/W

9. Characteristics

Table 9. Characteristics

1805 MHz $\leq f \leq$ 2200 MHz; $V_{\text{CC}} = 1.8\text{ V}$; $V_{\text{I(CTRL)}} \geq 0.8\text{ V}$; $T_{\text{amb}} = 25\text{ }^{\circ}\text{C}$; input matched to 50 Ω using a 4.7 nH inductor in series; see [Figure 4](#) unless otherwise specified.

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
Gain mode						
I_{CC}	supply current	$V_{\text{I(CTRL)}} \geq 0.8\text{ V}$	-	4.1	-	mA
G_{p}	power gain	$f = 1843\text{ MHz}$	[1]	16.7	-	dB
		$f = 1960\text{ MHz}$	[2]	16.3	-	dB
		$f = 2140\text{ MHz}$	[3]	15.4	-	dB

Table 9. Characteristics ...continued

1805 MHz $\leq f \leq$ 2200 MHz; $V_{CC} = 1.8$ V; $V_{I(CTRL)} \geq 0.8$ V; $T_{amb} = 25$ °C; input matched to 50 Ω using a 4.7 nH inductor in series; see [Figure 4](#) unless otherwise specified.

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
RL _{in}	input return loss	f = 1843 MHz [1]	-	6.0	-	dB
		f = 1960 MHz [2]	-	7.0	-	dB
		f = 2140 MHz [3]	-	9.0	-	dB
RL _{out}	output return loss	f = 1843 MHz [1]	-	15	-	dB
		f = 1960 MHz [2]	-	11	-	dB
		f = 2140 MHz [3]	-	8	-	dB
ISL	isolation	f = 1843 MHz [1]	-	25	-	dB
		f = 1960 MHz [2]	-	25	-	dB
		f = 2140 MHz [3]	-	25	-	dB
NF	noise figure	f = 1843 MHz [1][4]	-	0.8	-	dB
		f = 1960 MHz [2][4]	-	0.8	-	dB
		f = 2140 MHz [3][4]	-	0.85	-	dB
P _{I(1dB)}	input power at 1 dB gain compression	f = 1843 MHz [1]	-	-11.0	-	dBm
		f = 1960 MHz [2]	-	-10.5	-	dBm
		f = 2140 MHz [3]	-	-9.5	-	dBm
IP3 _i	input third-order intercept point	f = 1843 MHz [1]	-	-2.0	-	dBm
		f = 1960 MHz [2]	-	-1.0	-	dBm
		f = 2140 MHz [3]	-	-1.5	-	dBm
t _{on}	turn-on time	time from V _{I(CTRL)} ON, to 90 % of the gain	-	-	4	μ s
t _{off}	turn-off time	time from V _{I(CTRL)} OFF, to 10 % of the gain	-	-	1	μ s
Bypass mode						
I _{CC}	supply current	V _{I(CTRL)} < 0.3 V	-	-	1	μ A
G _p	power gain	f = 1843 MHz [1]	-	-2.8	-	dB
		f = 1960 MHz [2]	-	-2.9	-	dB
		f = 2140 MHz [3]	-	-3.1	-	dB
RL _{in}	input return loss	f = 1843 MHz [1]	-	14	-	dB
		f = 1960 MHz [2]	-	13	-	dB
		f = 2140 MHz [3]	-	12	-	dB
RL _{out}	output return loss	f = 1843 MHz [1]	-	9.0	-	dB
		f = 1960 MHz [2]	-	8.5	-	dB
		f = 2140 MHz [3]	-	8.0	-	dB

[1] E_UTRA operating band 3 (1805 MHz to 1880 MHz).

[2] E_UTRA operating band 2 (1930 MHz to 1990 MHz).

[3] E_UTRA operating band 1 (2110 MHz to 2170 MHz).

[4] PCB losses are subtracted

Table 10. Characteristics

1805 MHz $\leq f \leq$ 2200 MHz; $V_{CC} = 2.8$ V; $V_{I(CTRL)} \geq 0.8$ V; $T_{amb} = 25$ °C; input matched to 50 Ω using a 4.7 nH inductor in series; [Figure 4](#) unless otherwise specified.

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
Gain mode						
I_{CC}	supply current	$V_{I(CTRL)} \geq 0.8$ V	-	4.4	-	mA
G_p	power gain	f = 1843 MHz [1]	-	17.0	-	dB
		f = 1960 MHz [2]	-	16.6	-	dB
		f = 2140 MHz [3]	-	15.8	-	dB
RL_{in}	input return loss	f = 1843 MHz [1]	-	6.0	-	dB
		f = 1960 MHz [2]	-	7.5	-	dB
		f = 2140 MHz [3]	-	9.5	-	dB
RL_{out}	output return loss	f = 1843 MHz [1]	-	15	-	dB
		f = 1960 MHz [2]	-	11.5	-	dB
		f = 2140 MHz [3]	-	8	-	dB
ISL	isolation	f = 1843 MHz [1]	-	25	-	dB
		f = 1960 MHz [2]	-	25	-	dB
		f = 2140 MHz [3]	-	25	-	dB
NF	noise figure	f = 1843 MHz [1][4]	-	0.75	-	dB
		f = 1960 MHz [2][4]	-	0.80	-	dB
		f = 2140 MHz [3][4]	-	0.85	-	dB
$P_{I(1dB)}$	input power at 1 dB gain compression	f = 1843 MHz [1]	-	-7.5	-	dBm
		f = 1960 MHz [2]	-	-6.5	-	dBm
		f = 2140 MHz [3]	-	-5.5	-	dBm
$IP3_i$	input third-order intercept point	f = 1843 MHz [1]	-	-1.0	-	dBm
		f = 1960 MHz [2]	-	-0.5	-	dBm
		f = 2140 MHz [3]	-	-1.0	-	dBm
t_{on}	turn-on time	time from $V_{I(CTRL)}$ ON, to 90 % of the gain	-	-	4	μ s
t_{off}	turn-off time	time from $V_{I(CTRL)}$ OFF, to 10 % of the gain	-	-	1	μ s
Bypass mode						
I_{CC}	supply current	$V_{I(CTRL)} < 0.3$ V	-	-	1	μ A
G_p	power gain	f = 1843 MHz [1]	-	-2.5	-	dB
		f = 1960 MHz [2]	-	-2.7	-	dB
		f = 2140 MHz [3]	-	-3.0	-	dB
RL_{in}	input return loss	f = 1843 MHz [1]	-	13	-	dB
		f = 1960 MHz [2]	-	12	-	dB
		f = 2140 MHz [3]	-	11.0	-	dB

Table 10. Characteristics ...continued
1805 MHz ≤ f ≤ 2200 MHz; V_{CC} = 2.8 V; V_{I(CTRL)} ≥ 0.8 V; T_{amb} = 25 °C; input matched to 50 Ω using a 4.7 nH inductor in series; [Figure 4](#) unless otherwise specified.

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
RL _{out}	output return loss	f = 1843 MHz [1]	-	9.0	-	dB
		f = 1960 MHz [2]	-	8.5	-	dB
		f = 2140 MHz [3]	-	8.0	-	dB

- [1] E_UTRA operating band 3 (1805 MHz to 1880 MHz).
[2] E_UTRA operating band 2 (1930 MHz to 1990 MHz).
[3] E_UTRA operating band 1 (2110 MHz to 2170 MHz).
[4] PCB losses are subtracted

10. Application information

10.1 LTE LNA

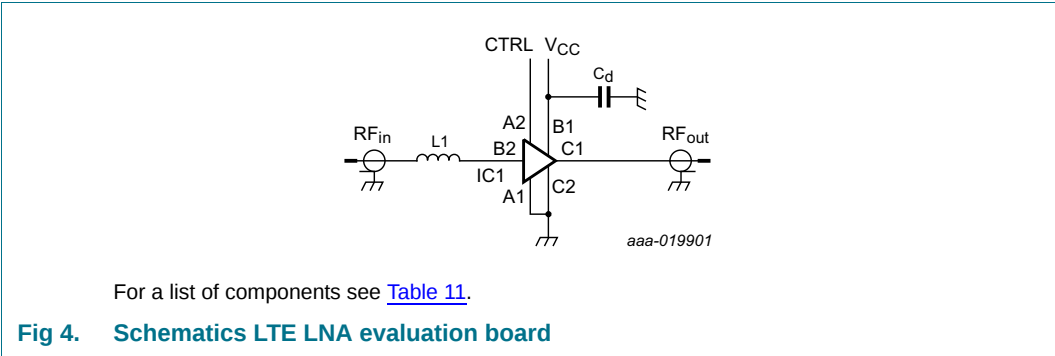


Table 11. List of components

For schematics see [Figure 4](#)

Component	Description	Value	Remarks
C _d	decoupling capacitor	1 uF	to suppress power supply noise
IC1	BGS8M4UK	-	NXP Semiconductors N.V.
L1	high-quality matching inductor	4.7 nH	Murata LQW15A

11. Package outline

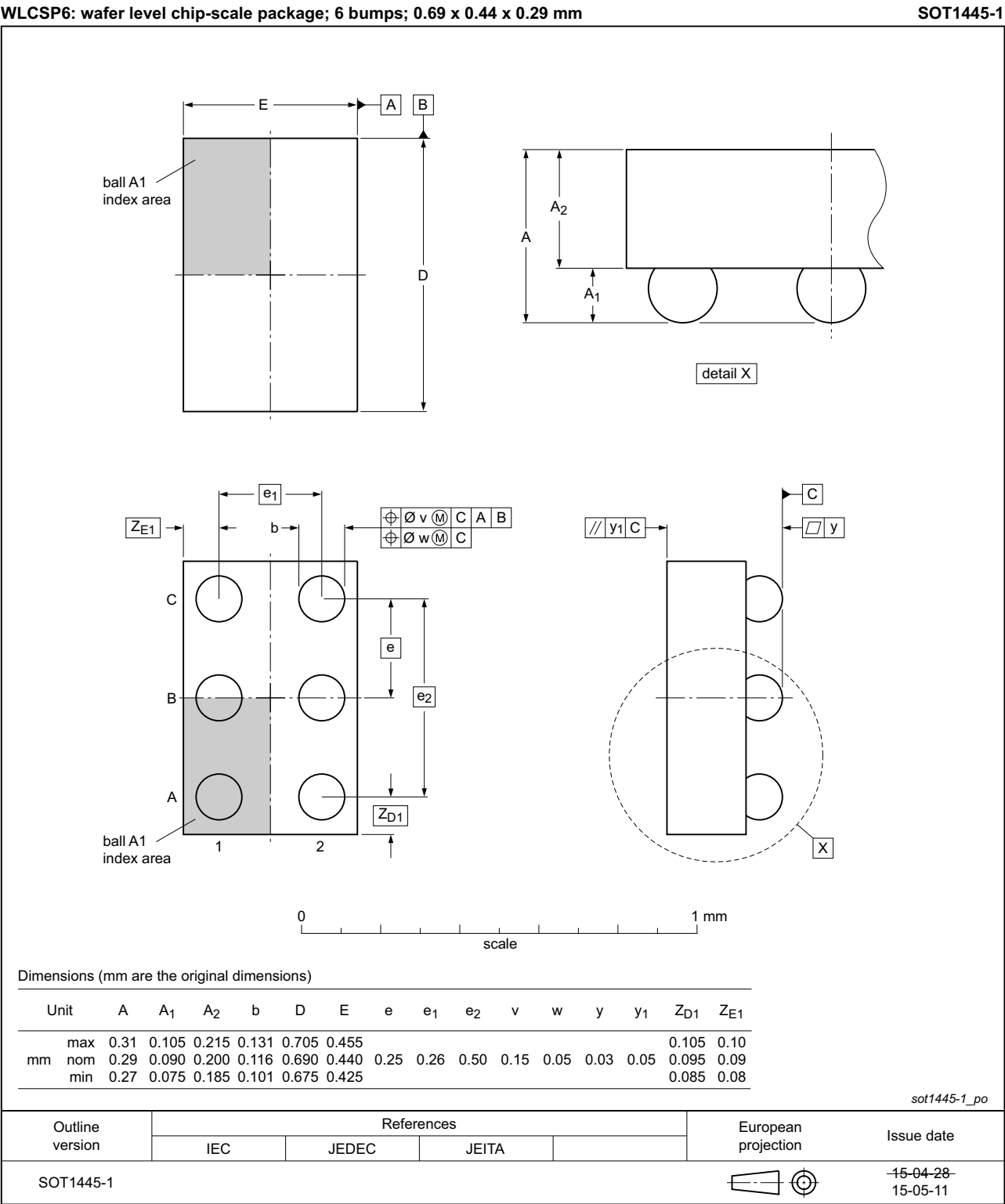


Fig 5. Package outline SOT1445-1 (WLCSP6)

12. Handling information

CAUTION



This device is sensitive to ElectroStatic Discharge (ESD). Observe precautions for handling electrostatic sensitive devices.

Such precautions are described in the *ANSI/ESD S20.20*, *IEC/ST 61340-5*, *JESD625-A* or equivalent standards.

13. Mounting

This WLCSP is only to be used in an overmolded module (using MUF)

14. Abbreviations

Table 12. Abbreviations

Acronym	Description
ESD	ElectroStatic Discharge
HBM	Human Body Model
LTE	Long Term Evolution
MMIC	Monolithic Microwave Integrated Circuit
MUF	Molded UnderFill
PCB	Printed-Circuit Board
SiGe:C	Silicon Germanium Carbon

15. Revision history

Table 13. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
BGS8M4UK v.1	20151201	Product data sheet	-	-

16. Legal information

16.1 Data sheet status

Document status ^{[1][2]}	Product status ^[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
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